TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (L^2 - π -MOSV)

2SJ401

DC-DC Converter, Relay Drive and Motor Drive Applications

• 4-V gate drive

Low drain-source ON resistance : RDS (ON) = 33 mΩ (typ.)
 High forward transfer admittance : | Yfs | = 20 S (typ.)

• Low leakage current : $I_{DSS} = -100 \,\mu\text{A} \,(\text{max}) \,(V_{DS} = -60 \,\text{V})$

• Enhancement mode : $V_{th} = -0.8 \sim -2.0 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-60	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	-60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	-20	Α	
	Pulse(Note 1)	I _{DP}	-80	Α	
Drain power dissipation	n (Tc = 25°C)	P_{D}	100	W	
Single pulse avalanche energy (Note 2)		E _{AS}	800	mJ	
Avalanche current		I _{AR}	-20	Α	
Repetitive avalenche energy (Note 3)		E _{AR}	10	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.25	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

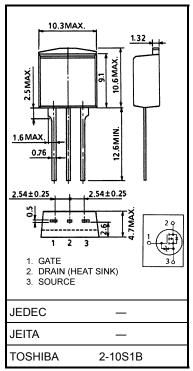
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = -50 V, T_{ch} = 25°C (initial), L = 1.44 mH, R_G = 25 Ω , I_{AR} = -20 A

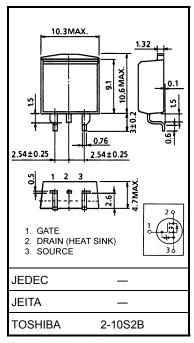
Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

Unit: mm



Weight: 1.5 g (typ.)



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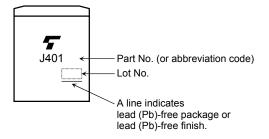
Electrical Characteristics (Ta = 25°C)

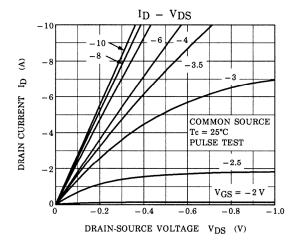
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = -60 V, V _{GS} = 0 V	_	_	-100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I _D = -10 mA, V _{GS} = 0 V	-60	_	_	V
Gate threshold	voltage	V _{th}	V _{DS} = -10 V, I _D = -1 mA	-0.8	_	-2.0	V
D : 011 : 1		R _{DS (ON)}	V _{GS} = -4 V, I _D = -10 A	_	50	90	0
Drain-source ON resistance	V _{GS} = -10 V, I _D = -10 A		_	33	45	mΩ	
Forward transfe	r admittance	Y _{fs}	V _{DS} = -10 V, I _D = -10 A	10	20	_	S
Input capacitano	ce	C _{iss}			2800	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	450	_	pF
Output capacitance		C _{oss}			1300	_	
Switching time	Rise time	t _r	$V_{GS} = 10V$ $V_{GS} = 10V$ $V_{GS} = 10V$ $R_{L} = 3\Omega$	_	15	_	- ns
	Turn-on time	t _{on}		_	35	_	
	Fall time	t _f		_	25	_	
	Turn-off time	t _{off}	$V_{DD} = -30V$ $Duty \le 1\%, \ t_{W} = 10\mu s$	_	120	_	
Total gate charge (Gate-source plus gate-drain)		Qg	V _{DD} ≈ -48 V, V _{GS} = -10 V, I _D = -20 A		90		nC
Gate-source charge		Q _{gs}			65	_	
Gate-drain ("miller") charge		Q _{gd}			25		

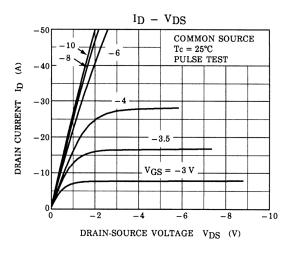
Source-Drain Ratings and Characteristics (Ta = 25°C)

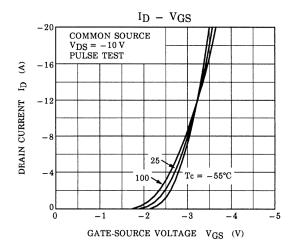
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	-20	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	-80	А
Forward voltage (diode)	V _{DSF}	I _{DR} = -20 A, V _{GS} = 0 V	_	_	1.7	V
Reverse recovery time	t _{rr}	I _{DR} = -20 A, V _{GS} = 0 V	ı	75		ns
Reverse recovery charge	Qrr	dl _{DR} / dt = 50 A / μs	1	83	_	nC

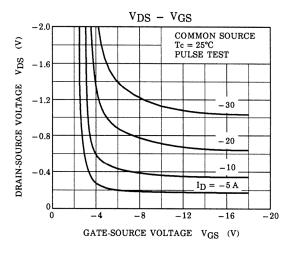
Marking

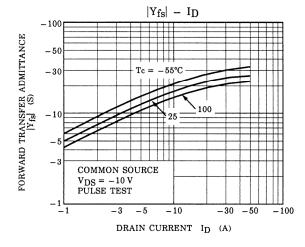


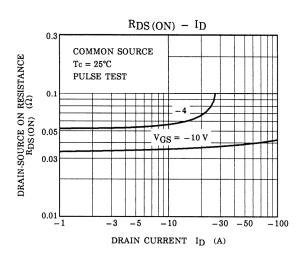


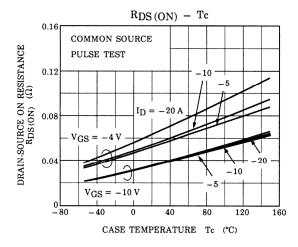


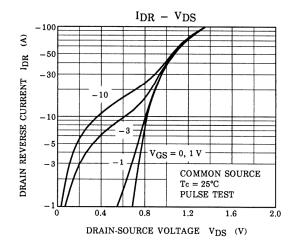


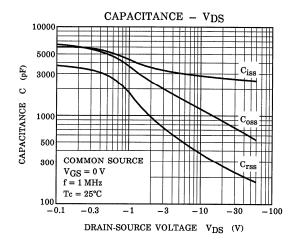


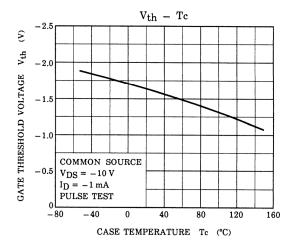


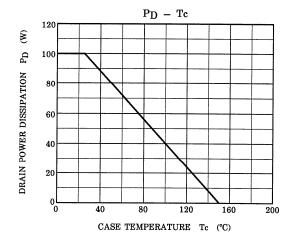


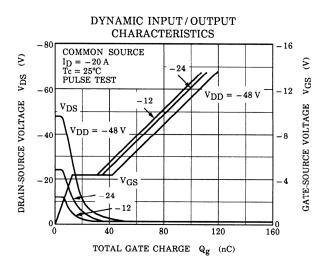


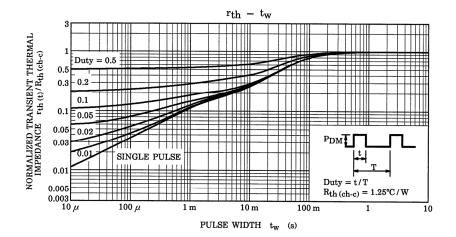


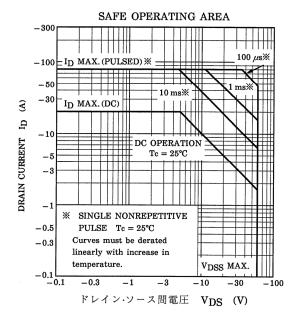


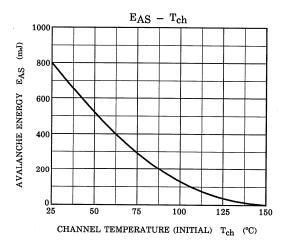


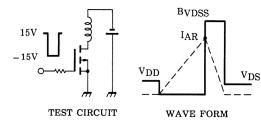












$$R_G = 25\Omega$$

 $V_{DD} = -50V$, L=1.44mH

$$E_{AS} \!=\! \frac{1}{2} \cdot L \cdot I^2 \cdot (\frac{B_{VDSS}}{B_{VDSS} \!-\! V_{DD}})$$

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20070701-EN

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